			Application/Control No. Applicant			pplicant(s)/P	(s)/Patent Under		
Notice of References Cited					10/800,636		R	Reexamination HASEGAWA ET AL.	
					Examiner John L. Goodrow		Aı	t Unit	
							17	7 56	Page 1 of 1
				U.S. P	ATENT DOCU	MENTS			
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name					Classification
*	Α	US-6,844,067	01-2005	Shimo et al.					428/402
*	В	US-5,199,983	04-1993	Katamoto, Tsutomu					106/459
*	С	US-2003/0186155	10-2003	Aoki et al.					430/111.4
*	D	US-6,969,574	11-2005	Tosaka et al.					430/137.18
	Е	US-					····		
	F	US-							
	G	US-							
	Н	US-					-		
	1	US-							
	7	US-							
	K	US-							
	L	US-			•				
	М	US-							
FOREIGN PATENT DOCUMENTS									
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	C	ountry Name			Classification	
	N								
	0								
	Р	*****				ļ			
	Q					ļ			
	R	<u> </u>							
	S								
	Ţ					<u> </u>			
					ATENT DOCUI				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	U								
	٧								

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

W

Х